- Choice of Operating Speeds
 High-Speed, A Devices . . . 25 MHz Min
 Half-Power, A-2 Devices . . . 16 MHz Min
- Choice of Input/Output Configuration
- Package Options Include Both Ceramic DIP and Chip Carrier in Addition to Ceramic Flat Package

DEVICE	I INPUTS	3-STATE O OUTPUTS	REGISTERED Q OUTPUTS	I/O PORT S
PAL16L8	10	2	0	6
PAL16R4	8	0	4 (3-state buffers)	4
PAL16R6	8	0	6 (3-state buffers)	2
PAL16R8	8	0	8 (3-state buffers)	0

description

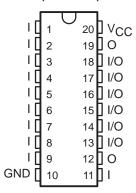
These programmable array logic devices feature high speed and a choice of either standard or half-power devices. They combine Advanced Low-Power Schottky technology with proven titanium-tungsten fuses. These devices will provide reliable, high-performance substitutes for conventional TTL logic. Their easy programmability allow for quick design of "custom" functions and typically results in a more compact circuit board. In addition, chip carriers are available for further reduction in board space.

The Half-Power versions offer a choice of operating frequency, switching speeds, and power dissipation. In many cases, these Half-Power devices can result in significant power reduction from an overall system level.

The PAL16' M series is characterized for operation over the full military temperature range of –55°C to 125°C.

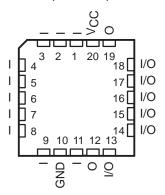
PAL16L8'
J OR W PACKAGE

(TOP VIEW)



PAL16L8' FK PACKAGE

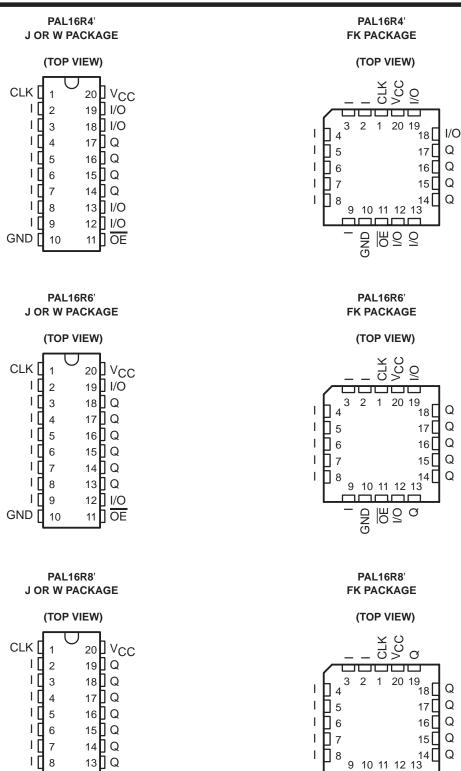
(TOP VIEW)



PAL is a registered trademark of Advanced Micro Devices Inc.

PAL16R4AM, PAL16R4A-2M, PAL16R6AM, PAL16R6A-2M, PAL16R8AM, PAL16R8A-2M STANDARD HIGH-SPEED PAL^{\circledR} CIRCUITS

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GND Q Q Q

12 Q

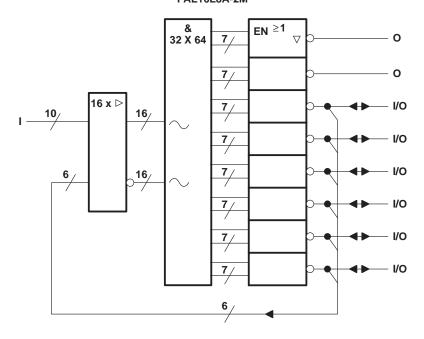
11 OE

GND [

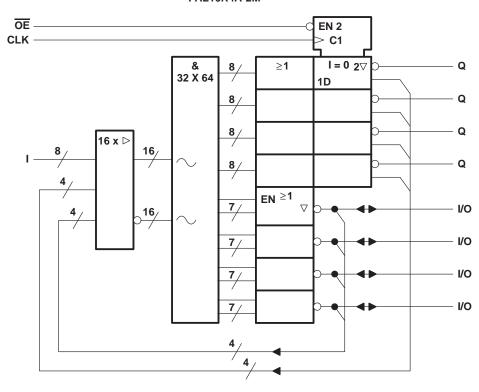
10

functional block diagrams (positive logic)

PAL16L8AM PAL16L8A-2M



PAL16R4AM PAL16R4A-2M

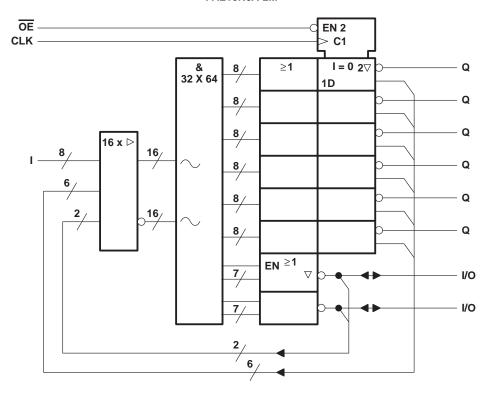


outputs denotes fused inputs

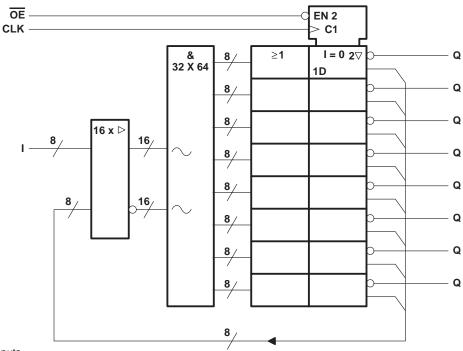


functional block diagrams (positive logic)

PAL16R6AM PAL16R6A-2M



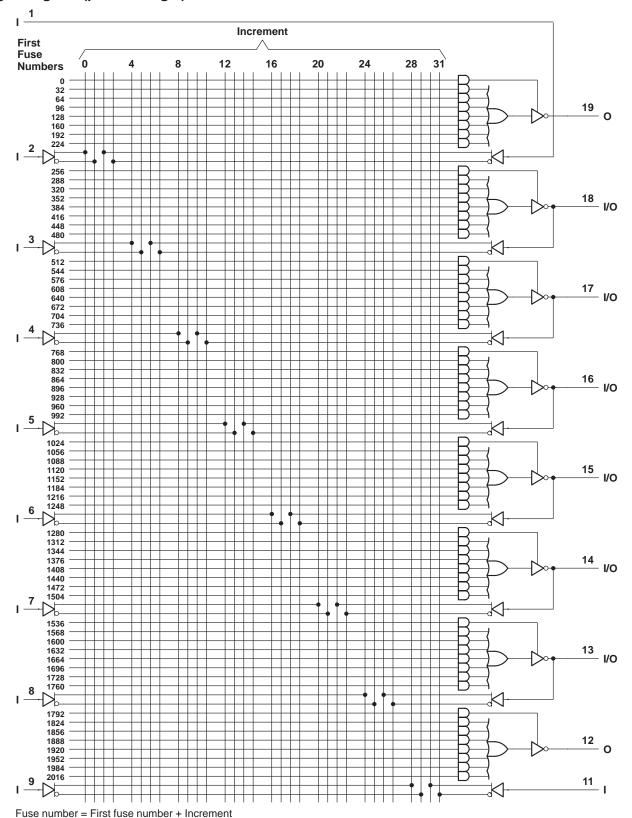
PAL16R8AM PAL16R8A-2M



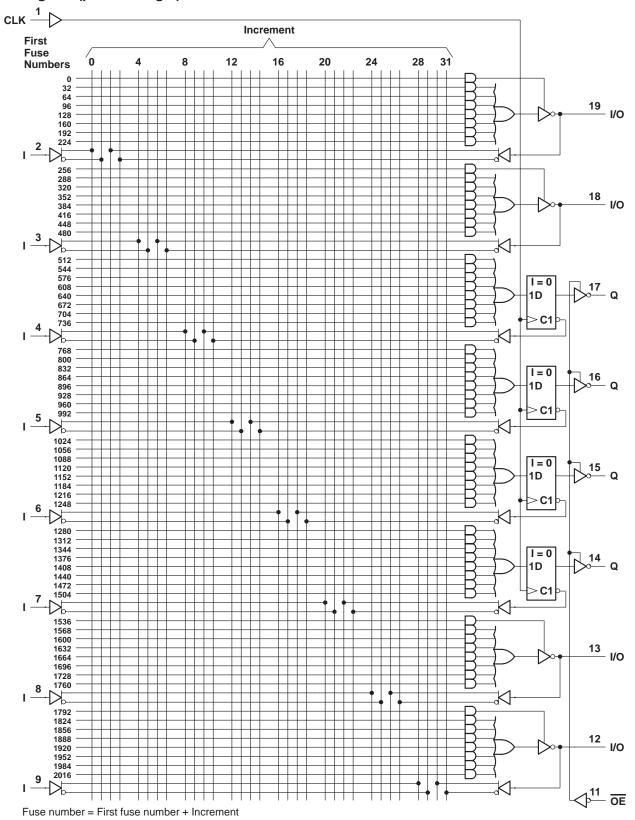
 \sim denotes fused inputs



logic diagram (positive logic)

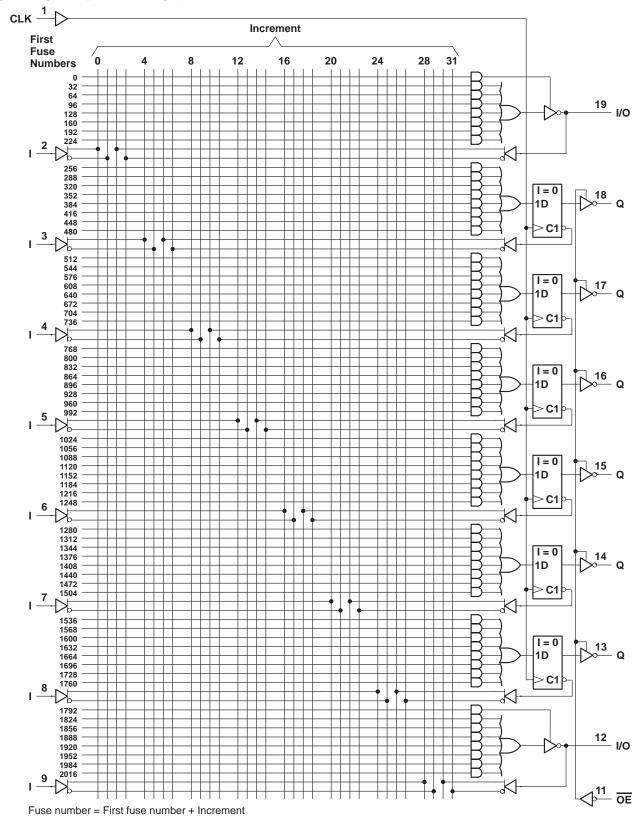


logic diagram (positive logic)



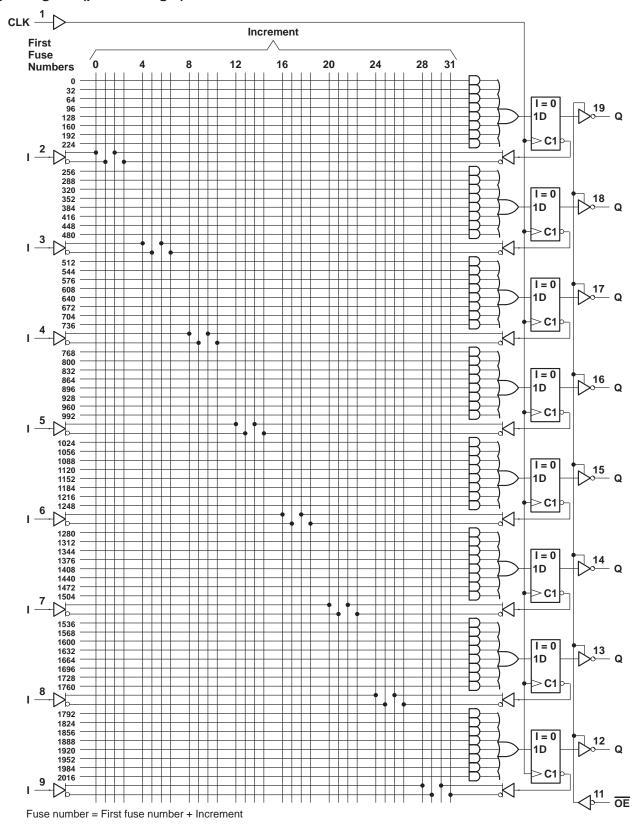


logic diagram (positive logic)



7

logic diagram (positive logic)





PAL16L8AM, PAL16L8A-2M, PAL16R4AM, PAL16R4A-2M PAL16R6AM, PAL16R6A-2M, PAL16R8AM, PAL16R8A-2M STANDARD HIGH-SPEED *PAL*® CIRCUITS

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programming information

Texas Instruments programmable logic devices can be programmed using widely available software and inexpensive device programmers.

Complete programming specifications, algorithms, and the latest information on hardware, software, and firmware are available upon request. Information on programmers capable of programming Texas Instruments programmable logic is also available, upon request, from the nearest TI field sales office, local authorized TI distributor, or by calling Texas Instruments at (214) 997-5666.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)		. 7 V
Input voltage (see Note 1)		5.5 V
Voltage applied to disabled output (see Note 1)		5.5 V
Operating free-air temperature range	−55°C to	125°C
Storage temperature range	−65°C to	150°C

NOTE 1: These ratings apply except for programming pins during a programming cycle.

recommended operating conditions

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2		5.5	V
VIL	Low-level input voltage			0.8	V
ЮН	High-level output current			-2	mA
loL	Low-level output current			12	mA
TA	Operating free-air temperature	-55	25	125	°C

PAL16L8AM, PAL16R4AM, PAL16R6AM, PAL16R8AM STANDARD HIGH-SPEED PAL^{\circledR} CIRCUITS

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electrical characteristics over recommended operating free-air temperature range

PAR	RAMETER		TEST CONDITIONS	3	MIN	TYP [†]	MAX	UNIT	
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$				-1.5	V	
Vон		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$		2.4	3.2		V	
VOL		$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 12 \text{ mA}$			0.25	0.4	V	
I	Outputs	\\ F F \\	V = - 2.7 V				20	^	
lozh	I/O ports	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$				100	μА	
lo-	Outputs	\\	V 0.4V				-20	^	
lozL	I/O ports	$V_{CC} = 5.5 V,$	$V_0 = 0.4 \text{ V}$				-100	00 μA	
Ц		V _{CC} = 5.5 V,	V _I = 5.5 V				0.2	mA	
L	I/O Ports	V 55V	V- 07V				100	^	
lΗ	All others	$V_{CC} = 5.5 V,$	V _I = 2.7 V				25	μА	
	OE input		V 0.4V				-0.2	^	
ΊL	All others	$V_{CC} = 5.5 V,$	$V_{ } = 0.4 \text{ V}$				-0.1	mA	
los‡	-	V _{CC} = 5.5 V,	V _O = 0.5 V		-30		-250	mA	
Icc	·	V _{CC} = 5.5 V,	V _I = 0,	Outputs open		75	180	mA	

timing requirements

			MIN	MAX	UNIT
fclock	Clock Frequency		0	25	MHz
t	Dulas direction (see Nata 2)	Clock high	15		
ι _W	Pulse duration (see Note 2)	20		ns	
t _{su}	Setup time, input or feedback before CLK↑	25		ns	
t _h	Hold time, input or feedback after CLK↑		0		ns

NOTE 2: The total clock period of clock high and clock low must not exceed clock frequency, f_{clock}. The minimum pulse durations specified are only for clock high or low, but not for both simultaneously.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITION	MIN	TYP	MAX	UNIT
f _{max}				25	45		MHz
^t pd	I, I/O	O, I/O			15	30	ns
t _{pd}	CLK↑	Q	R1 = 390 Ω ,		10	20	ns
t _{en}	OE↓	Q	$R2 = 750 \Omega$,		15	25	ns
^t dis	OE↑	Q	See Figure 1		10	25	ns
t _{en}	I, I/O	O, I/O			14	30	ns
t _{dis}	I, I/O	O, I/O			13	30	ns

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[‡] Not more than one output should be shorted at a time and the duration of the short circuit should not exceed one second. Set V_O at 0.5 V to avoid test equipment degradation.

electrical characteristics over recommended operating free-air temperature range

PAR	AMETER		TEST CONDITION	s	MIN	TYP [†]	MAX	UNIT	
VIK		$V_{CC} = 4.5 V,$	$I_{I} = -18 \text{ mA}$				-1.5	V	
Vон		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$		2.4	3.2		V	
VOL		$V_{CC} = 4.5 V$,	$I_{OL} = 12 \text{ mA}$			0.25	0.4	V	
1	Outputs	\\\ \- \- \- \- \- \- \- \- \- \- \\	V 2.7.V				20		
lozh	I/O ports	$V_{CC} = 5.5 \text{ V},$	$V_O = 2.7 \text{ V}$				100	μΑ	
lozi	Outputs	\/	V- 04V				-20	^	
lozL	I/O ports	$V_{CC} = 5.5 \text{ V},$	VO = 0.4 V	$V_0 = 0.4 \text{ V}$			-100	μΑ	
lį		$V_{CC} = 5.5 V$,	V _I = 5.5 V				0.2	mA	
1	I/O Ports	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	\\. 07\\				100		
ΙΗ	All others	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V				25	μΑ	
	OE input	\/ F.F.\/	V 0.4V				-0.2	A	
lı∟	All others	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V				-0.1	mA	
los [‡]	·	$V_{CC} = 5.5 \text{ V},$	V _O = 0.5 V		-30		-250	mA	
Icc		$V_{CC} = 5.5 \text{ V},$	V _I = 0,	Outputs open		75	90	mA	

timing requirements

			MIN	MAX	UNIT
fclock	Clock Frequency		0	16	MHz
t	Dulas duration (see Nate 2)	Clock high	25		
ιW	Pulse duration (see Note 2)	25		ns	
t _{su}	Setup time, input or feedback before CLK↑		35		ns
t _h	Hold time, input or feedback after CLK↑	•	0		ns

NOTE 2: The total clock period of clock high and clock low must not exceed clock frequency, f_{clock}. The minimum pulse durations specified are only for clock high or low, but not for both simultaneously.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

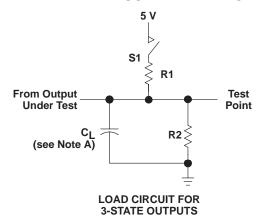
PARAMETER	FROM	ТО	TEST CONDITION		TYPT	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	TEST CONDITION	MIN	ITPI	WAX	UNIT
f _{max}				16	25		MHz
^t pd	I, I/O	O, I/O			25	40	ns
^t pd	CLK↑	Q	R1 = 390 Ω ,		11	25	ns
t _{en}	OE↓	Q	R2 = 750 Ω ,		20	25	ns
^t dis	OE↑	Q	See Figure 1		11	25	ns
t _{en}	I, I/O	O, I/O			25	40	ns
^t dis	I, I/O	O, I/O			25	35	ns

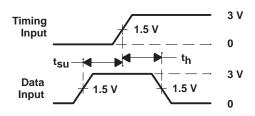
[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



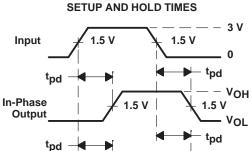
[‡] Not more than one output should be shorted at a time and the duration of the short circuit should not exceed one second. Set V_O at 0.5 V to avoid test equipment degradation.

PARAMETER MEASUREMENT INFORMATION





VOLTAGE WAVEFORMS

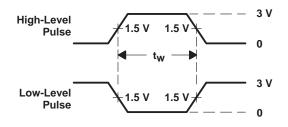


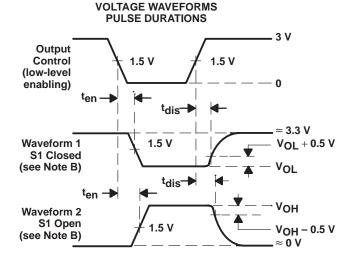
VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES

Out-of-Phase

(see Note D)

Output





VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS

NOTES: A. C_L includes probe and jig capacitance and is 50 pF for t_{pd} and t_{en} , 5 pF for t_{dis} .

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses have the following characteristics: PRR \leq 10 MHz, t_{Γ} and $t_{f} \leq$ 2 ns, duty cycle = 50%
- D. When measuring propagation delay times of 3-state outputs, switch S1 is closed.

Vон

VOI

1.5 V

E. Equivalent loads may be used for testing.

Figure 1. Load Circuit and Voltage Waveforms









PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
81036072A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103607RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103607SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
81036082A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103608RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103608SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
81036092A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103609RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103609SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
81036102A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103610RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103610SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
81036112A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103611RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103611SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
81036122A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103612RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103612SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
81036132A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103613RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103613SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
81036142A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
8103614RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
8103614SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8A-2MFKE	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8A-2MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8A-2MJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8A-2MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8AMFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8AMJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8AMJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16L8AMWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4A-2MFKE	B ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4A-2MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4A-2MJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4A-2MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4AMFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4AMJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4AMJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R4AMWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R6A-2MFKE	B ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R6A-2MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type



PACKAGE OPTION ADDENDUM

12-Jan-2006

Orderable Device	Status ⁽¹⁾	Package	Package	Pins	Package	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
DALACDOA OMID	A OTIVE	Type	Drawing	200	Qty	TDD	C-II TI	N / A for Directions
PAL16R6A-2MJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R6A-2MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R6AMFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R6AMJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R6AMJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R6AMWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8A-2MFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8A-2MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8A-2MJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8A-2MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8AMFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8AMJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8AMJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
PAL16R8AMWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within Mil-Std 1835 GDFP2-F20



FK (S-CQCC-N**)

28 TERMINAL SHOWN

LEADLESS CERAMIC CHIP CARRIER



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. The terminals are gold plated.
- E. Falls within JEDEC MS-004



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Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Interface	interface.ti.com	Digital Control	www.ti.com/digitalcontrol
Logic	logic.ti.com	Military	www.ti.com/military
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